

Features

- Temperature ranges
 - Commercial: 0°C to 70°C
 - Industrial: -40°C to 85°C
 - Automotive-A: -40°C to 85°C
 - Automotive-E: -40°C to 125°C
- Pin and function compatible with CY7C1041BV33
- High speed
 - t_{AA} = 10 ns (Commercial, Industrial and Automotive-A)
 - t_{AA} = 12 ns (Automotive-E)
- Low active power
 - 324 mW (max)
- 2.0V data retention
- Automatic power down when deselected
- TTL-compatible inputs and outputs
- Easy memory expansion with \overline{CE} and \overline{OE} features
- Available in Pb-free and non Pb-free 44-pin 400 Mil SOJ, 44-pin TSOP II and 48-Ball FBGA packages

Functional Description

The CY7C1041CV33 is a high performance CMOS static RAM organized as 262,144 words by 16 bits.

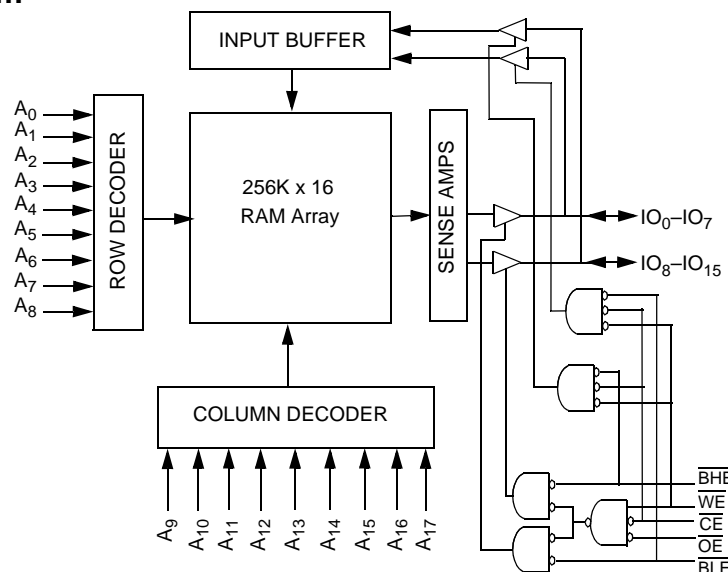
To write to the device, take Chip Enable (\overline{CE}) and Write Enable (\overline{WE}) inputs LOW. If Byte Low Enable (\overline{BLE}) is LOW, then data from IO pins (IO_0 through IO_7), is written into the location specified on the address pins (A_0 through A_{17}). If Byte High Enable (\overline{BHE}) is LOW, then data from IO pins (IO_8 through IO_{15}) is written into the location specified on the address pins (A_0 through A_{17}).

To read from the device, take Chip Enable (\overline{CE}) and Output Enable (\overline{OE}) LOW while forcing the Write Enable (\overline{WE}) HIGH. If Byte Low Enable (\overline{BLE}) is LOW, then data from the memory location specified by the address pins appear on IO_0 to IO_7 . If Byte High Enable (\overline{BHE}) is LOW, then data from memory appears on IO_8 to IO_{15} . For more information, see the [Truth Table](#) on page 9 for a complete description of Read and Write modes.

The input and output pins (IO_0 through IO_{15}) are placed in a high impedance state when the device is deselected (\overline{CE} HIGH), the outputs are disabled (\overline{OE} HIGH), the \overline{BHE} and \overline{BLE} are disabled (\overline{BHE} , \overline{BLE} HIGH), or during a write operation (\overline{CE} LOW and \overline{WE} LOW).

For best practice recommendations, refer to the Cypress application note [AN1064, SRAM System Guidelines](#).

Logic Block Diagram



Description		-10	-12	-15	-20	Unit
Maximum Access Time		10	12	15	20	ns
Maximum Operating Current	Commercial	90	85	80	75	mA
	Industrial	100	95	90	85	mA
	Automotive-A	100			85	mA
	Automotive-E		120		90	mA
Maximum CMOS Standby Current	Commercial/ Industrial	10	10	10	10	mA
	Automotive-A	10			10	mA
	Automotive-E		15		15	mA

	1	2	3	4	5	6	
A	$\overline{\text{BLE}}$	$\overline{\text{OE}}$	A_0	A_1	A_2	NC	
B	IO_0	$\overline{\text{BHE}}$	A_3	A_4	$\overline{\text{CE}}$	IO_8	
C	IO_1	IO_2	A_5	A_6	IO_{10}	IO_9	
D	V_{SS}	IO_3	A_{17}	A_7	IO_{11}	V_{CC}	
E	V_{CC}	IO_4	NC	A_{16}	IO_{12}	V_{SS}	
F	IO_6	IO_5	A_{14}	A_{15}	IO_{13}	IO_{14}	
G	IO_7	NC	A_{12}	A_{13}	$\overline{\text{WE}}$	IO_{15}	
H	NC	A_8	A_9	A_{10}	A_{11}	NC	

[+] Feedback

Pin Definitions

Pin Name	SOJ, TSOP Pin Number	BGA Pin Number	IO Type	Description
A ₀ –A ₁₇	1–5, 18–27, 42–44	A3, A4, A5, B3, B4, C3, C4, D4, H2, H3, H4, H5, G3, G4, F3, F4, E4, D3	Input	Address Inputs. Used to select one of the address locations.
IO ₀ –IO ₁₅	7–10, 13–16, 29–32, 35–38	B1, C1, C2, D2, E2, F2, F1, G1, B6, C6, C5, D5, E5, F5, F6, G6	Input or Output	Bidirectional Data IO lines. Used as input or output lines depending on operation.
NC	28	A6, E3, G2, H1, H6	No Connect	No Connects. Not connected to the die.
$\overline{\text{WE}}$	17	G5	Input or Control	Write Enable Input, Active LOW. When selected LOW, a write is conducted. When deselected HIGH, a read is conducted.
$\overline{\text{CE}}$	6	B5	Input or Control	Chip Enable Input, Active LOW. When LOW, selects the chip. When HIGH, deselects the chip.
$\overline{\text{BHE}}, \overline{\text{BLE}}$	40, 39	B2, A1	Input or Control	Byte Write Select Inputs, Active LOW. $\overline{\text{BHE}}$ controls IO ₁₆ – IO ₉ , $\overline{\text{BLE}}$ controls IO ₈ – IO ₁ .
$\overline{\text{OE}}$	41	A2	Input or Control	Output Enable, Active LOW. Controls the direction of the IO pins. When LOW, the IO pins are allowed to behave as outputs. When deasserted HIGH, the IO pins are tri-stated and act as input data pins.
V _{SS}	12, 34	D1, E6	Ground	Ground for the Device. Connected to ground of the system.
V _{CC}	11, 33	D6, E1	Power Supply	Power Supply Inputs to the Device.

Maximum Ratings

Exceeding maximum ratings may impair the useful life of the device. These user guidelines are not tested.

Storage Temperature -65°C to +150°C

Ambient Temperature with
Power Applied -55°C to +125°C

Supply Voltage on V_{CC} Relative to GND^[2] -0.5V to +4.6V

DC Voltage Applied to Outputs
in High Z State^[2] -0.5V to $V_{CC}+0.5V$

DC Input Voltage^[2] -0.5V to $V_{CC}+0.5V$

Current into Outputs (LOW) 20 mA

Static Discharge Voltage >2001V
(MIL-STD-883, Method 3015)

Latch Up Current >200 mA

Operating Range

Range	Ambient Temperature (T_A)	V_{CC}
Commercial	0°C to +70°C	3.3V ± 10%
Industrial	-40°C to +85°C	
Automotive-A	-40°C to +85°C	
Automotive -E	-40°C to +125°C	

Electrical Characteristics

Over the Operating Range

Parameter	Description	Test Conditions	-10		-12		-15		-20		Unit
			Min	Max	Min	Max	Min	Max	Min	Max	
V_{OH}	Output HIGH Voltage	$V_{CC} = \text{Min}, I_{OH} = -4.0 \text{ mA}$	2.4		2.4		2.4		2.4		V
V_{OL}	Output LOW Voltage	$V_{CC} = \text{Min}, I_{OL} = 8.0 \text{ mA}$		0.4		0.4		0.4		0.4	V
V_{IH}	Input HIGH Voltage		2.0	$V_{CC} + 0.3$	2.0	$V_{CC} + 0.3$	2.0	$V_{CC} + 0.3$	2.0	$V_{CC} + 0.3$	V
$V_{IL}^{[2]}$	Input LOW Voltage		-0.3	0.8	-0.3	0.8	-0.3	0.8	-0.3	0.8	V
I_{IX}	Input Leakage Current	$GND \leq V_I \leq V_{CC}$	Com'l/Ind'l		Auto-A		Auto-E				μA
			-1	+1	-1	+1	-1	+1	-1	+1	
			-1	+1	-20	+20	-20	+20	-20	+20	
I_{OZ}	Output Leakage Current	$GND \leq V_{OUT} \leq V_{CC}$, Output disabled	Com'l/Ind'l		Auto-A		Auto-E				μA
			-1	+1	-1	+1	-1	+1	-1	+1	
			-1	+1	-20	+20	-20	+20	-20	+20	
I_{CC}	V_{CC} Operating Supply Current	$V_{CC} = \text{Max},$ $f = f_{MAX} = 1/t_{RC}$	Com'l		Ind'l		Auto-A		Auto-E		mA
				90		85		80		75	
				100		95		90		85	
				100						85	
I_{SB1}	Automatic CE Power Down Current — TTL Inputs	Max V_{CC} , $CE \geq V_{IH}$, $V_{IN} \geq V_{IH}$ or $V_{IN} \leq V_{IL}$, $f = f_{MAX}$	Com'l/Ind'l		Auto-A		Auto-E				mA
				40		40		40		40	
				40						40	
I_{SB2}	Automatic CE Power Down Current — CMOS Inputs	Max V_{CC} , $CE \geq V_{CC} - 0.3V$, $V_{IN} \geq V_{CC} - 0.3V$, or $V_{IN} \leq 0.3V$, $f = 0$	Com'l/Ind'l		Auto-A		Auto-E				mA
				10		10		10		10	
				10						10	

Note

2. $V_{IL}(\text{min}) = -2.0V$ and $V_{IH}(\text{max}) = V_{CC} + 0.5V$ for pulse durations of less than 20 ns.

Capacitance

Tested initially and after any design or process changes that may affect these parameters.

Parameter	Description	Test Conditions	Max	Unit
C _{IN}	Input Capacitance	T _A = 25°C, f = 1 MHz, V _{CC} = 3.3V	8	pF
C _{OUT}	Output Capacitance		8	pF

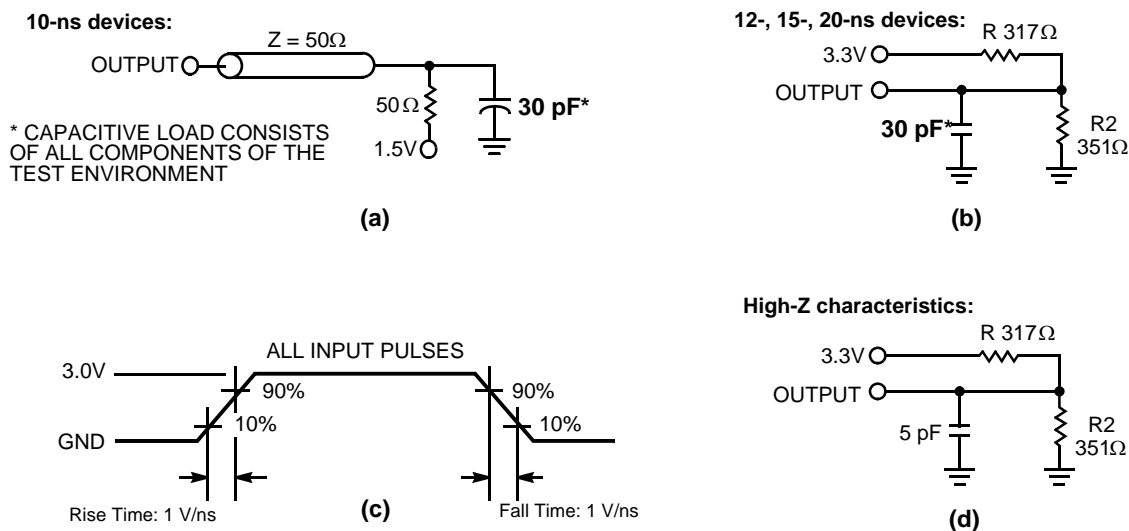
Thermal Resistance

Tested initially and after any design or process changes that may affect these parameters.

Parameter	Description	Test Conditions	SOJ	TSOP II	FBGA	Unit
Θ _{JA}	Thermal Resistance (Junction to Ambient)	Test conditions follow standard test methods and procedures for measuring thermal impedance, per EIA/JESD51	25.99	42.96	38.15	°C/W
Θ _{JC}	Thermal Resistance (Junction to Case)		18.8	10.75	9.15	°C/W

AC Test Loads and Waveforms

Figure 3. AC Test Loads and Waveforms [3]



Note

3. AC characteristics (except High-Z) for 10-ns parts are tested using the load conditions shown in Figure (a). All other speeds are tested using the Thevenin load shown in Figure (b). High-Z characteristics are tested for all speeds using the test load shown in Figure (d).

Switching Characteristics

Over the Operating Range ^[4]

Parameter	Description		-10		-12		-15		-20		Unit
			Min	Max	Min	Max	Min	Max	Min	Max	
Read Cycle											
t _{power} ^[5]	V _{CC} (Typical) to the First Access		100		100		100		100		μs
t _{RC}	Read Cycle Time		10		12		15		20		ns
t _{AA}	Address to Data Valid			10		12		15		20	ns
t _{OHA}	Data Hold from Address Change		3		3		3		3		ns
t _{ACE}	CE LOW to Data Valid			10		12		15		20	ns
t _{DOE}	OE LOW to Data Valid	Comm'l/Ind'l/Auto-A		5		6		7		8	ns
		Auto-E				7				8	
t _{LZOE}	OE LOW to Low Z ^[6]		0		0		0		0		ns
t _{HZOE}	OE HIGH to High Z ^[6, 7]			5		6		7		8	ns
t _{LZCE}	CE LOW to Low Z ^[6]		3		3		3		3		ns
t _{HZCE}	CE HIGH to High Z ^[6, 7]			5		6		7		8	ns
t _{PU}	CE LOW to Power Up		0		0		0		0		ns
t _{PD}	CE HIGH to Power Down			10		12		15		20	ns
t _{DBE}	Byte Enable to Data Valid	Comm'l/Ind'l/Auto-A		5		6		7		8	ns
		Auto-E				7				8	
t _{LZBE}	Byte Enable to Low Z		0		0		0		0		ns
t _{HZBE}	Byte Disable to High Z			6		6		7		8	ns
Write Cycle ^[8, 9]											
t _{WC}	Write Cycle Time		10		12		15		20		ns
t _{SCE}	CE LOW to Write End		7		8		10		10		ns
t _{AW}	Address Setup to Write End		7		8		10		10		ns
t _{HA}	Address Hold from Write End		0		0		0		0		ns
t _{SA}	Address Setup to Write Start		0		0		0		0		ns
t _{PWE}	WE Pulse Width		7		8		10		10		ns
t _{SD}	Data Setup to Write End		5		6		7		8		ns
t _{HD}	Data Hold from Write End		0		0		0		0		ns
t _{LZWE}	WE HIGH to Low Z ^[6]		3		3		3		3		ns
t _{HZWE}	WE LOW to High Z ^[6, 7]			5		6		7		8	ns
t _{BW}	Byte Enable to End of Write		7		8		10		10		ns

Notes

- Test conditions assume signal transition time of 3 ns or less, timing reference levels of 1.5V, and input pulse levels of 0 to 3.0V.
- t_{POWER} gives the minimum amount of time that the power supply is at typical V_{CC} values until the first memory access is performed.
- At any temperature and voltage condition, t_{HZCE} is less than t_{LZCE} , t_{HZBE} is less than t_{LZBE} , t_{HZOE} is less than t_{LZOE} , and t_{HZWE} is less than t_{LZWE} for any device.
- t_{HZOE} , t_{HZCE} , t_{HZBE} , and t_{HZWE} are specified with a load capacitance of 5 pF as in part (d) of [AC Test Loads and Waveforms](#) on page 5. Transition is measured ± 500 mV from steady state voltage.
- The internal write time of the memory is defined by the overlap of $\overline{\text{CE}}$ LOW, $\overline{\text{WE}}$ LOW, and $\overline{\text{BHE}}/\overline{\text{BLE}}$ LOW. $\overline{\text{CE}}$, $\overline{\text{WE}}$, and $\overline{\text{BHE}}/\overline{\text{BLE}}$ must be LOW to initiate a write. The transition of these signals terminate the write. The input data setup and hold timing is referenced to the leading edge of the signal that terminates the write.
- The minimum Write cycle time for Write Cycle No. 3 (WE controlled, OE LOW) is the sum of t_{HZWE} and t_{SD} .

Switching Waveforms

Figure 4. Read Cycle No. 1 (Address Transition Controlled)^[10, 11]

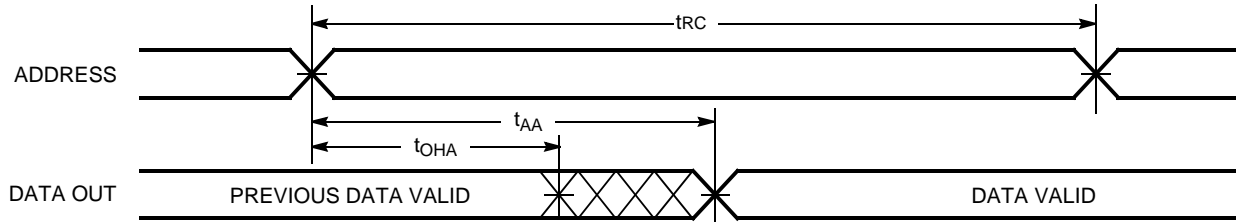
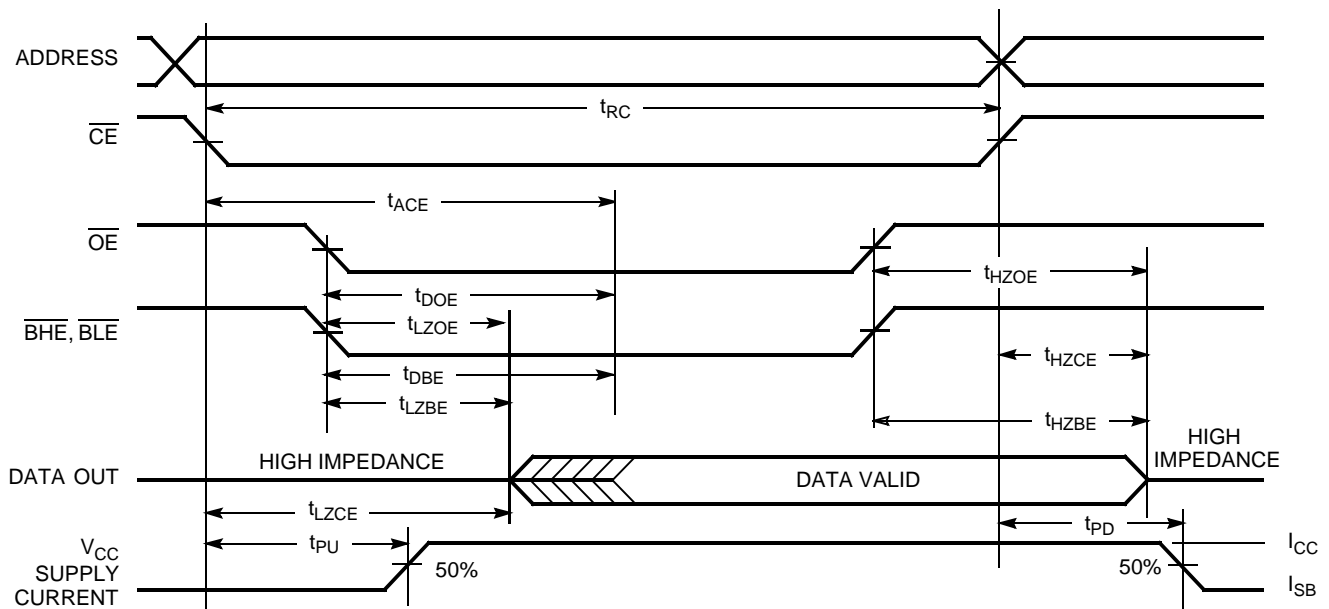


Figure 5. Read Cycle No. 2 ($\overline{\text{OE}}$ Controlled)^[11, 12]



Notes

10. Device is continuously selected. $\overline{\text{OE}}$, $\overline{\text{CE}}$, $\overline{\text{BHE}}$, and/or $\overline{\text{BLE}} = V_{\text{IL}}$.
11. $\overline{\text{WE}}$ is HIGH for read cycle.
12. Address valid prior to or coincident with $\overline{\text{CE}}$ transition LOW.

Switching Waveforms (continued)

Figure 6. Write Cycle No. 1 ($\overline{\text{CE}}$ Controlled)^[13, 14]

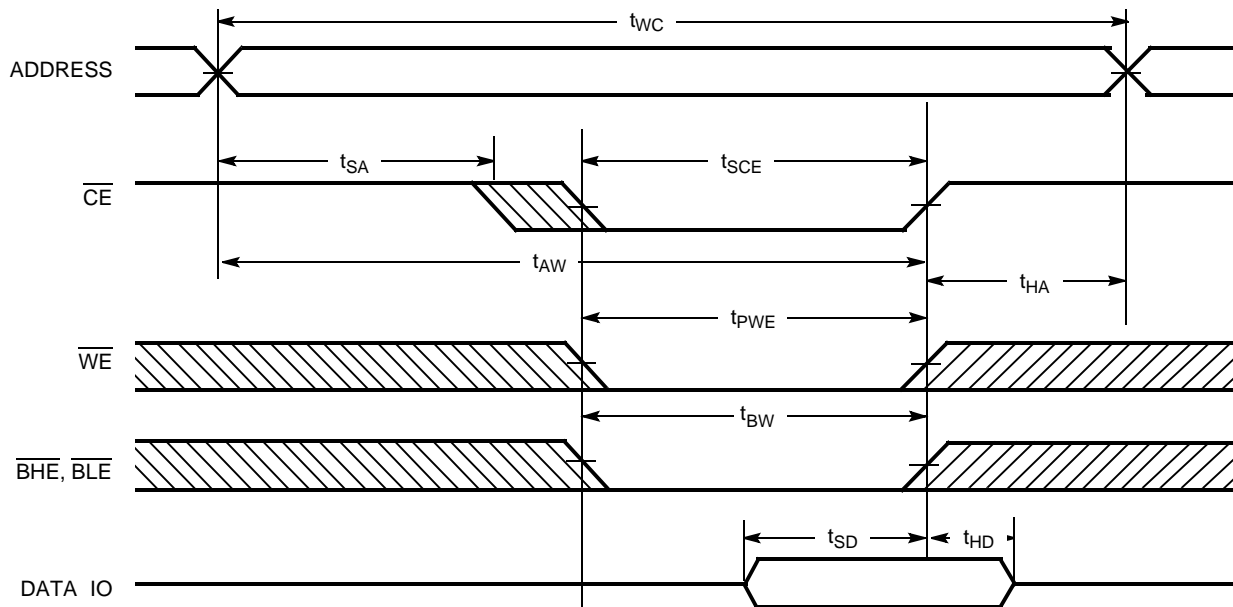
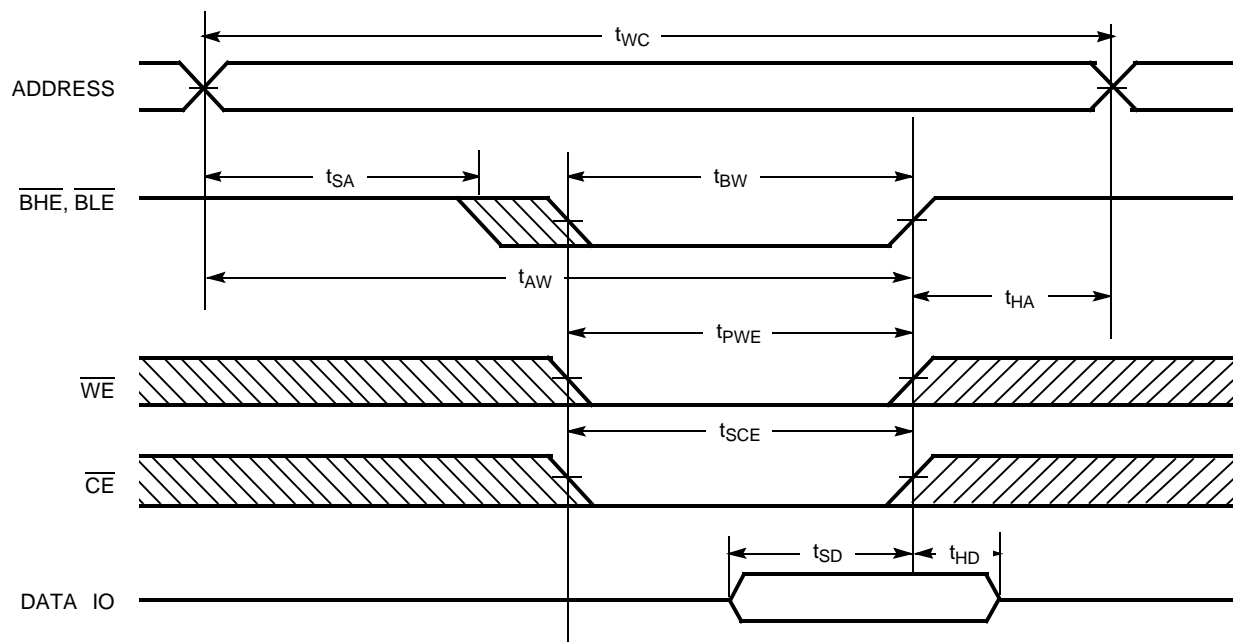


Figure 7. Write Cycle No. 2 ($\overline{\text{BLE}}$ or $\overline{\text{BHE}}$ Controlled)

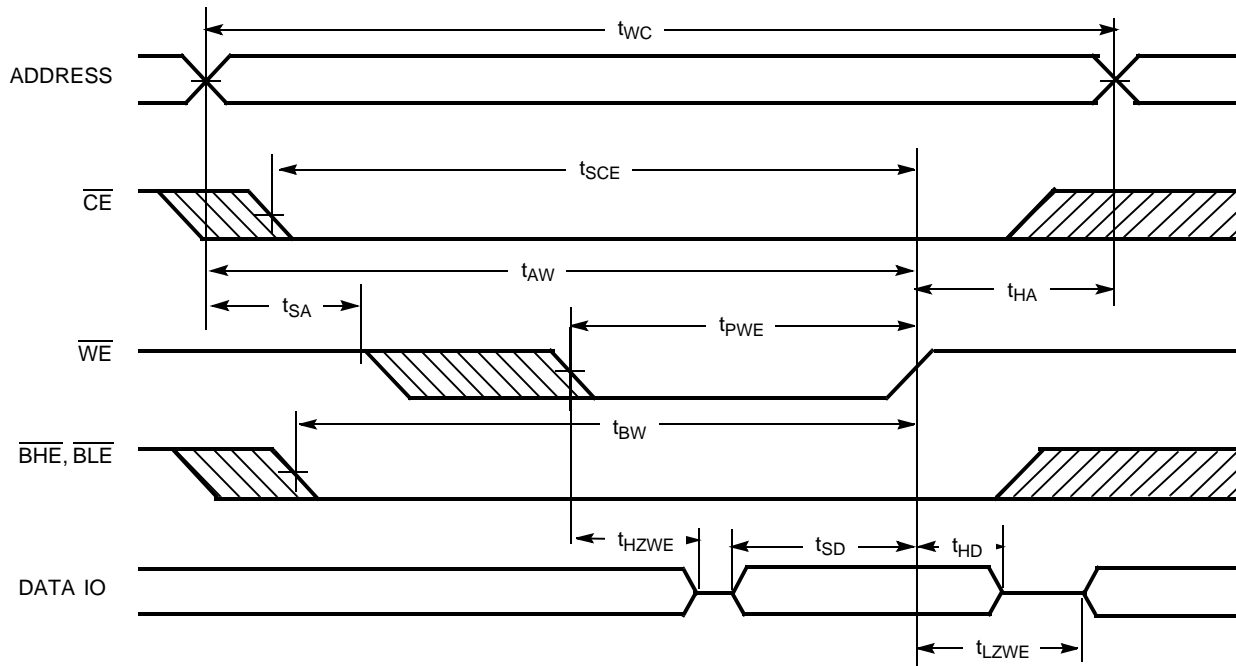


Notes

13. Data IO is high impedance if $\overline{\text{OE}}$, $\overline{\text{BHE}}$, and/or $\overline{\text{BLE}}$ = V_{IH} .

14. If $\overline{\text{CE}}$ goes HIGH simultaneously with $\overline{\text{WE}}$ going HIGH, the output remains in a high impedance state.

Switching Waveforms (continued)

Figure 8. Write Cycle No. 3 ($\overline{\text{WE}}$ Controlled, $\overline{\text{OE}}$ LOW)

Truth Table

$\overline{\text{CE}}$	$\overline{\text{OE}}$	$\overline{\text{WE}}$	$\overline{\text{BLE}}$	$\overline{\text{BHE}}$	$\text{IO}_0 - \text{IO}_7$	$\text{IO}_8 - \text{IO}_{15}$	Mode	Power
H	X	X	X	X	High Z	High Z	Power Down	Standby (I_{SB})
L	L	H	L	L	Data Out	Data Out	Read – All Bits	Active (I_{CC})
			L	H	Data Out	High Z	Read – Lower Bits Only	Active (I_{CC})
			H	L	High Z	Data Out	Read – Upper Bits Only	Active (I_{CC})
L	X	L	L	L	Data In	Data In	Write – All Bits	Active (I_{CC})
			L	H	Data In	High Z	Write – Lower Bits Only	Active (I_{CC})
			H	L	High Z	Data In	Write – Upper Bits Only	Active (I_{CC})
L	H	H	X	X	High Z	High Z	Selected, Outputs Disabled	Active (I_{CC})
L	X	X	H	H	High Z	High Z	Selected, Outputs Disabled	Active (I_{CC})

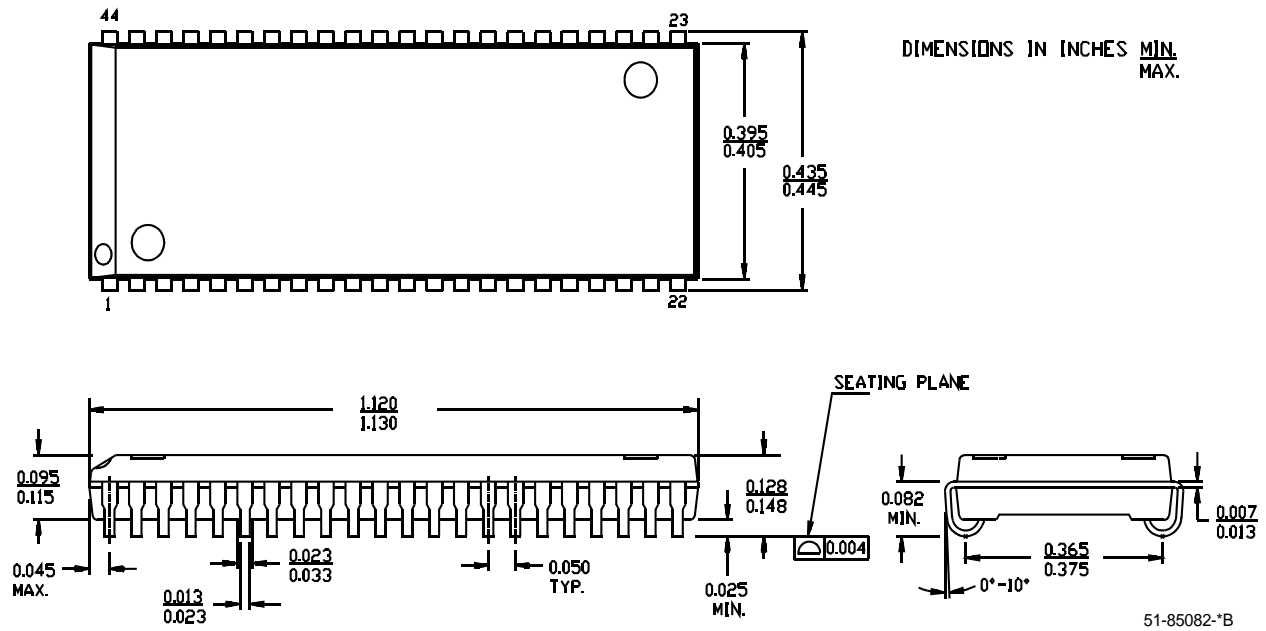
Ordering Information

Speed (ns)	Ordering Code	Package Diagram	Package Type	Operating Range
10	CY7C1041CV33-10BAXC	51-85106	48-ball Fine Pitch BGA (Pb-Free)	Commercial
	CY7C1041CV33-10VC	51-85082	44-pin (400-mil) Molded SOJ	
	CY7C1041CV33-10VXC		44-pin (400-mil) Molded SOJ (Pb-Free)	
	CY7C1041CV33-10ZXC	51-85087	44-pin TSOP II (Pb-Free)	
	CY7C1041CV33-10BAI	51-85106	48-ball Fine Pitch BGA	Industrial
	CY7C1041CV33-10BAXI		48-ball Fine Pitch BGA (Pb-Free)	
	CY7C1041CV33-10ZI	51-85087	44-pin TSOP II	
	CY7C1041CV33-10ZXI		44-pin TSOP II (Pb-Free)	
	CY7C1041CV33-10BAXA	51-85106	48-ball Fine Pitch BGA (Pb-Free)	Automotive-A
	CY7C1041CV33-10ZSXA	51-85087	44-pin TSOP II (Pb-Free)	
12	CY7C1041CV33-12VXC	51-85082	44-pin (400-mil) Molded SOJ (Pb-Free)	Commercial
	CY7C1041CV33-12ZXC	51-85087	44-pin TSOP II (Pb-Free)	Industrial
	CY7C1041CV33-12ZI	51-85087	44-pin TSOP II	
	CY7C1041CV33-12ZXI		44-pin TSOP II (Pb-Free)	
	CY7C1041CV33-12BAXE	51-85106	48-ball Fine Pitch BGA (Pb-Free)	Automotive-E
	CY7C1041CV33-12ZSXE	51-85087	44-pin TSOP II (Pb-Free)	
15	CY7C1041CV33-15ZXC	51-85087	44-pin TSOP II (Pb-Free)	Commercial
	CY7C1041CV33-15VI	51-85082	44-pin (400-mil) Molded SOJ	Industrial
	CY7C1041CV33-15VXI		44-pin (400-mil) Molded SOJ (Pb-Free)	
	CY7C1041CV33-15ZI	51-85087	44-pin TSOP II	
	CY7C1041CV33-15ZXI		44-pin TSOP II (Pb-Free)	
20	CY7C1041CV33-20ZC	51-85087	44-pin TSOP II	Commercial
	CY7C1041CV33-20ZSXA	51-85087	44-pin TSOP II (Pb-Free)	Automotive-A
	CY7C1041CV33-20VE	51-85082	44-pin (400-mil) Molded SOJ	Automotive-E
	CY7C1041CV33-20VXE		44-pin (400-mil) Molded SOJ (Pb-Free)	
	CY7C1041CV33-20ZE	51-85087	44-pin TSOP II	
	CY7C1041CV33-20ZSXE		44-pin TSOP II (Pb-Free)	

Please contact your local Cypress sales representative for availability of these parts

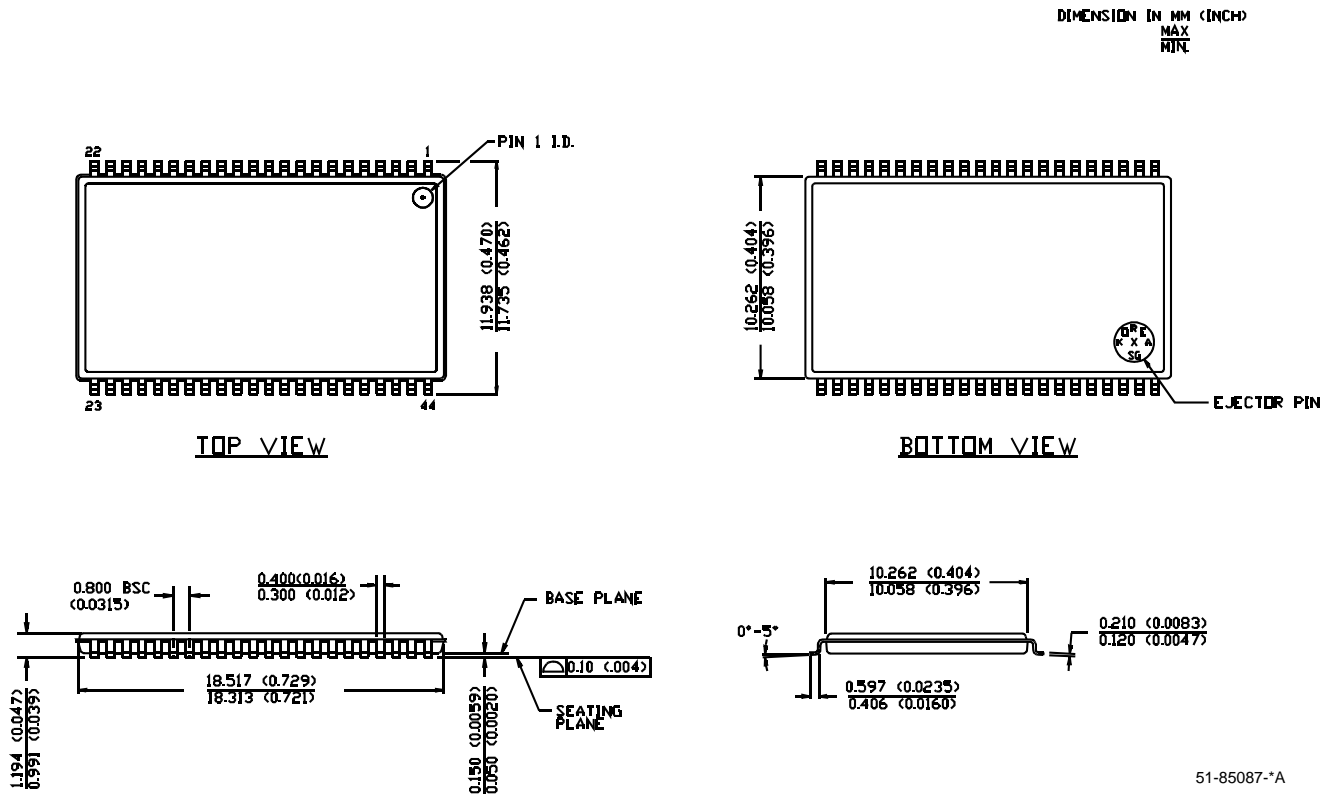
Package Diagrams

Figure 9. 44-Pin (400 Mil) Molded SOJ, 51-85082



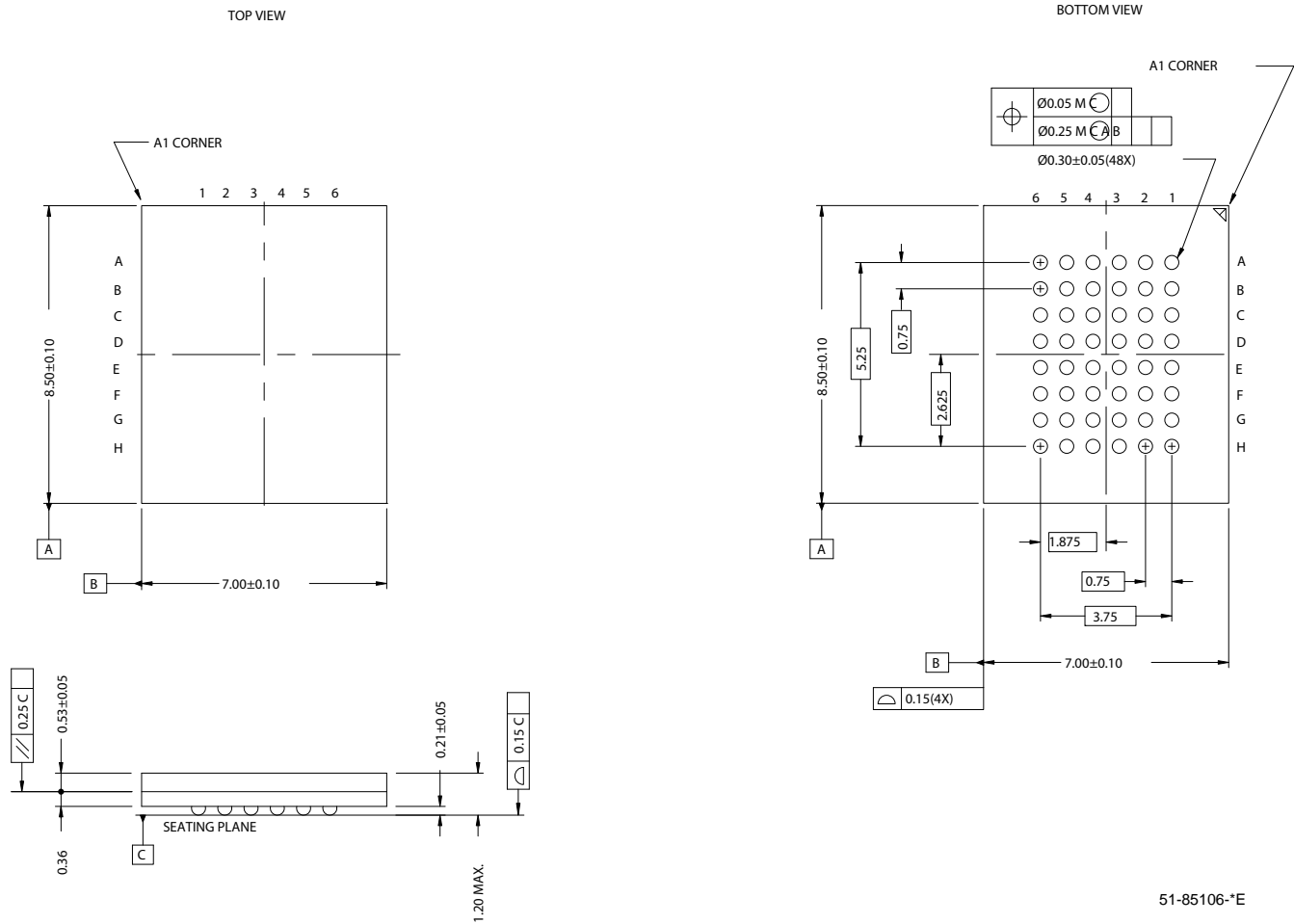
Package Diagrams (continued)

Figure 10. 44-Pin Thin Small Outline Package Type II, 51-85087



Package Diagrams (continued)

Figure 11. 48-Ball FBGA (7 x 8.5 x 1.2 mm), 51-85106



Document History Page

Document Title: CY7C1041CV33, 4-Mbit (256K x 16) Static RAM Document Number: 38-05134				
REV.	ECN NO.	Issue Date	Orig. of Change	Description of Change
**	109513	12/13/01	HGK	New Data Sheet
*A	112440	12/20/01	BSS	Updated 51-85106 from revision *A to *C
*B	112859	03/25/02	DFP	Added CY7C1042CV33 in BGA package Removed 1042 BGA option pin ACC Final Data Sheet
*C	116477	09/16/02	CEA	Add applications foot note to data sheet
*D	119797	10/21/02	DFP	Added 20-ns speed bin
*E	262949	See ECN	RKF	1) Added Lead (Pb)-Free parts in the Ordering info (Page #9) 2) Added Automotive Specs to Datasheet
*F	361795	See ECN	SYT	Added Pb-Free offerings in the Ordering Information
*G	435387	See ECN	NXR	Removed -8 Speed bin from Product offering. Corrected typo in description for BHE/BLE in pin definitions table on Page# 3 corrected their Pin name from OE2 to OE. Included the Maximum Ratings for Static Discharge Voltage and Latch up Current. Changed the description of I _{IX} current from Input Load Current to Input Leakage Current Added note# 4 on page# 4 Updated the Ordering Information table
*H	499153	See ECN	NXR	Added Automotive-A Operating Range Changed t _{power} value from 1 μs to 100 μs Updated Ordering Information table
*I	2104110	See ECN	VKN/AESA	Added Automotive-E specs for 12 ns speed Updated Ordering Information table

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